

Search Notes

Application/Control No.

10/664,671

Examiner

Shean C. Wu

Applicant(s)/Patent under
Reexamination

INOUE ET AL.

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
CAS on line structure search, see attachment	7/2/2007	SW